## AK09973D

## 3D Magnetic Smart Switch Sensor

## 1. General Description

AK09973D is a 3D magnetic smart switch sensor IC with high sensitivity and wide measurement range utilizing our latest Hall sensor technology.
Our ultra-small package of AK09973D incorporates magnetic sensors, chopper stabilized signal amplifier chain, and all necessary interface logic for detecting weak to strong magnetic fields in the Xaxis, Y -axis and Z -axis independently. From its compact foot print, thin package, and extremely low power consumption, it is suitable for a smartphone and wearable application.

## 2. Features

- Functions:
> 16-bit data out for each 3 -axis magnetic component
> Built-in A to D Converter for magnetometer data output
> Sensor measurement range and sensitivity
$\diamond$ High sensitivity setting
- Sensitivity: $1.1 \mu \mathrm{~T} / \mathrm{LSB}$ (typ.)
- Measurement range: $\pm 36 \mathrm{mT}$
* Wide range setting
- Sensitivity: $3.1 \mu \mathrm{~T} / \mathrm{LSB}$ (typ.)
- Measurement range: $X$ and $Y$-axis $\rightarrow \pm 34.9 \mathrm{mT}, \mathrm{Z}$-axis $\rightarrow \pm 101.5 \mathrm{mT}$
> Serial interface
$\diamond \quad I^{2} \mathrm{C}$ bus interface
Standard mode, Fast mode and Fast mode plus
$\triangleleft$ Two selectable slave addresses
> Operation mode
P Power-down, Single measurement, Continuous measurement, Self-test
> 3 -axis programmable switch function
> Output pin for event notification
$\checkmark$ OD-INT pin
> DRDY function for measurement data ready
> Magnetic sensor overflow monitor function
> Built-in power on reset function
- Built-in oscillator for internal clock source
> Selectable sensor drive
\& Low power drive / Low noise drive
- Operating temperature:
> $\quad-30^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
- Operating supply voltage:
$>\quad 1.65 \mathrm{~V}$ to 1.95 V
- Current consumption (VDD $=1.8 \mathrm{~V},+25^{\circ} \mathrm{C}$ ):
> Power-down: $1.0 \mu \mathrm{~A}$ (typ.)
> Measurement:
\& Average current consumption at $10 \mathrm{~Hz} / 100 \mathrm{~Hz}$ repetition rate
- Low power drive: $3.5 \mu \mathrm{~A}$ (typ.) at $10 \mathrm{~Hz}, 22 \mu \mathrm{~A}($ typ. $)$ at 100 Hz
- Low noise drive: $11 \mu \mathrm{~A}$ (typ.) at $10 \mathrm{~Hz}, 101 \mu \mathrm{~A}$ (typ.) at 100 Hz
- Package
$>$ AK09973D 5-pin WL-CSP $(B G A)$ package: $1.18 \mathrm{~mm} \times 0.78 \mathrm{~mm} \times 0.55 \mathrm{~mm}$


## 3. Table of Contents

1. General Description ..... 1
2. Features ..... 1
3. Table of Contents ..... 2
4. Block Diagram and Functions ..... 4
4.1. Block Diagram ..... 4
4.2. Functions ..... 4
5. Pin Configurations and Functions ..... 5
6. Absolute Maximum Ratings ..... 6
7. Recommended Operating Conditions ..... 6
8. Electrical Characteristics ..... 6
8.1. DC Characteristics ..... 6
8.2. AC Characteristics ..... 7
8.3. AC Characteristics of OD-INT ..... 8
8.4. Overall Characteristics ..... 9
8.5. ${ }^{2} \mathrm{C}$ Bus Interface ..... 10
9. Status Description ..... 11
9.1. State Transition Diagram ..... 11
9.2. Power States ..... 12
10. Functional Descriptions ..... 13
10.1. Reset Functions ..... 13
10.2. Operation modes ..... 13
10.2.1. Description of Each Operation Mode ..... 14
10.3. Data Ready ..... 14
10.3.1. Normal Measurement Data Read Sequence ..... 15
10.3.2. Data Read Start during Measurement ..... 16
10.3.3. Data Skip ..... 16
10.3.4. End Operation ..... 17
10.4. Programmable Switch Function ..... 17
10.5. Self-test Function ..... 18
10.6. Error Notification Function ..... 19
10.7. Interrupt Function ..... 19
10.7.1. Interrupt Event ..... 20
10.7.2. Timing of DRDY Interrupt Function Operation ..... 21
10.7.3. Timing of Switch/Error Interrupt Function Operation ..... 22
10.8. Sensor Drive Select ..... 23
10.9. Sensor Measurement Range and Sensitivity Select ..... 23
11. Serial Interface ..... 24
11.1. ${ }^{1}{ }^{2} \mathrm{C}$ Bus Interface ..... 24
11.1.1. Data Transfer ..... 24
11.1.2. WRITE Instruction ..... 26
11.1.3. READ Instruction ..... 27
12. Registers ..... 28
12.1. Description of Registers ..... 28
12.2. Register Map ..... 29
12.3. Detailed Description of Registers ..... 31
12.3.1 WIA[15:0]: Company ID and Device ID ..... 31
12.3.2 RSV[15:0]: Reserved Register ..... 31
12.3.3 ST[7:0]: Status ..... 31
12.3.4 HX[15:0]/HY[15:0]/HZ[15:0]: Measurement Data ..... 32
12.3.5 HV[23:0]: Sum of Squares of 3-axis Measurement Data ..... 33
12.3.6 CNTL1[15:0]: Interrupt Output Setting ..... 34
12.3.7 CNTL2[7:0]: Operation Mode, Sensor Drive and Self-test Setting ..... 35
12.3.8 BOP and BRP registers: Operating Threshold and Returning Threshold Setting of Programmable Switch Function ..... 36
12.3.9 SRST[7:0]: Soft Reset ..... 37
12.3.10 TEST1[15:0]/TEST2[7:0]: Test register ..... 37
13. Recommended External Circuits ..... 38
14. Package ..... 40
14.1. Outline Dimensions ..... 40
14.2. Marking ..... 40
14.3. Pin Assignment ..... 41
15. Magnetic Orientation ..... 42
IMPORTANT NOTICE ..... 43

## 4. Block Diagram and Functions

### 4.1. Block Diagram



### 4.2. Functions

| Block | Function |
| :---: | :---: |
| 3-axis Hall sensor | Monolithic Hall elements. |
| Chopper SW \& MUX | Multiplexer for selecting Hall elements. |
| Analog Regulator | Internal power supply. |
| Pre-AMP | Differential amplifier used to amplify the magnetic sensor signal. |
| ADC | Convert analog output to digital output. |
| OSC1 | Generates an operating clock for sensor measurement. |
| OSC2 | Generates an operating periodic clock for sequencer. |
| POR | Power On Reset circuit. Generates reset signal on rising edge of VDD. |
| VREF | Generates temperature independent reference voltage. |
| Interface Logic <br>  <br> Register | Exchanges data with an external CPU. <br> OD-INT pin indicates some magnetic event (selectable). <br> $1^{2} \mathrm{C}$ bus interface using two pins (SCL and SDA). Standard mode, Fast mode and Fast mode plus are supported. |
|  <br> Signal Processing | Generates a timing signal required for internal operation. Magnetic sensitivity adjustment and switch calculation for switch function. |
| Magnetic source | Generates magnetic field for Self-test of magnetic sensor. |

## 5. Pin Configurations and Functions

AK09973D has two pin connections shown in the tables below. The slave address can be switched by changing the pin connection.

Connection 1: Slave address $=10 \mathrm{~h}$

| Pin <br> No. | Pin name | Function <br> name | I/O | Type | Function |
| :--- | :--- | :--- | :--- | :--- | :--- |
| B1 | IF1 | OD-INT | O | Digital | Open-drain interrupt pin <br> "L" active. Refer to section 10.7. <br> Connect this pin to VSS when not using <br> OD-INT. |
| B3 | IF2 | SDA | I/O | Digital | Control data input/output pin <br> Input: Schmitt trigger, Output: Open-drain <br> A1 <br> VDD |
| V2 | VSS | VSS | - | Power | Positive power supply pin |
| A3 | SCL | SCL | I | Ground | Ground pin |

Connection 2: Slave address = 11 h

| Pin <br> No. | Pin name | Function <br> name | I/O | Type | Function |
| :--- | :--- | :--- | :--- | :--- | :--- |
| B1 | IF1 | SDA | I/O | Digital | Control data input/output pin <br> Input: Schmitt trigger, Output: Open-drain |
| B3 | IF2 | OD-INT | O | Digital | Open-drain interrupt pin <br> "L" active. Refer to section 10.7. <br> Connect this pin to VSS when not using <br> OD-INT. |
| A1 | VDD | VDD | - | Power | Positive power supply pin |
| A2 | VSS | VSS | - | Ground | Ground pin |
| A3 | SCL | SCL | I | Digital | Control clock input pin <br> Input: Schmitt trigger |

## 6. Absolute Maximum Ratings

$\mathrm{Vss}=0 \mathrm{~V}$

| Parameter | Symbol | Min. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Power supply voltage | Vdd | -0.3 | +2.5 | V |
| Input voltage | VIN | -0.3 | $\mathrm{Vdd}+0.3$ | V |
| Input current | IIN | -10 | +10 | mA |
| Storage temperature | Tst | -40 | +125 | ${ }^{\circ} \mathrm{C}$ |

## Note:

If the device is used in conditions exceeding these values, the device may be destroyed. Normal operations are not guaranteed in such exceeding conditions.

## 7. Recommended Operating Conditions

Vss $=0 \mathrm{~V}$

| Parameter | Symbol | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Operating temperature | Ta | -30 | - | +85 | ${ }^{\circ} \mathrm{C}$ |
| Power supply voltage | Vdd | 1.65 | 1.8 | 1.95 | V |
| Input voltage | VIN | 1.1 | 1.8 | Vdd | V |

## 8. Electrical Characteristics

The following conditions apply unless otherwise noted:
$\mathrm{Vdd}=1.65 \mathrm{~V}$ to $1.95 \mathrm{~V}, \quad \mathrm{VIN}=1.1 \mathrm{~V}$ to Vdd , Temperature range $=-30^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$
Typical condition: Vdd $=1.8 \mathrm{~V}$, Temperature $=+25^{\circ} \mathrm{C}$

### 8.1. DC Characteristics

| Parameter | Symbol | Pin | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| High level input voltage* ${ }^{1}$ | VIH | $\begin{aligned} & \hline \text { SCL } \\ & \text { IF1 } \\ & \text { IF2 } \end{aligned}$ | - | 1.00 | - | Vdd +0.3 | V |
| Low level input voltage* ${ }^{1}$ | VIL | $\begin{aligned} & \hline \text { SCL } \\ & \text { IF1 } \\ & \text { IF2 } \end{aligned}$ | - | -0.3 | - | 0.42 | V |
| Input current* ${ }^{\text {1 }}$ | IIN | $\begin{aligned} & \hline \text { SCL } \\ & \text { IF1 } \\ & \text { IF2 } \end{aligned}$ | $\begin{gathered} \quad \mathrm{VIN} \\ =\mathrm{Vss} \text { or } \mathrm{Vdd} \end{gathered}$ | -10 | - | +10 | $\mu \mathrm{A}$ |
| Hysteresis input voltage* ${ }^{2}$ | VHS | $\begin{aligned} & \text { SCL } \\ & \text { IF1 } \\ & \text { IF2 } \\ & \hline \end{aligned}$ | - | 0.15 | - | - | V |
| Low level output voltage | VOL | $\begin{aligned} & \hline \text { IF1 } \\ & \text { IF2 } \end{aligned}$ | $1 \mathrm{LL}^{* 3} \leq+20 \mathrm{~mA}$ | - | - | 0.33 | V |
| Current consumption* ${ }^{\text {a }}$ | IDD1 | VDD | Power-down mode VIN = Vdd | - | 1 | 3 | $\mu \mathrm{A}$ |
|  | IDD2 |  | When magnetic sensor is driven | - | 1.4 | 2.2 | mA |
|  | IDD3 |  | When self-test is driven | - | 5.6 | - | mA |

Notes:

* 1. As for IF1 and IF2 pins, the specification is applied when these pins are used for SDA function.
* 2. Schmitt trigger input (reference value for design).
* 3. IOL: Low level output current.
* 4. Without any resistance load.


### 8.2. AC Characteristics

| Parameter | Symbol | Pin | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Power supply rise time ${ }^{* 5}$ | PSUP | VDD | Period of time that VDD changes from 0.2 V to Vdd. | - | - | 50 | ms |
| POR completion time*5 | PORT |  | Period of time after PSUP to Power-down mode* 6 | - | - | 100 | $\mu \mathrm{s}$ |
| Power supply turn off voltage*5 | SDV |  | Turn off voltage to enable POR to restart 6 | - | - | 0.2 | V |
| Power supply turn on interval ${ }^{*} 5$ | PSINT |  | Period of time that voltage lower than SDV needed to be kept to enable POR to restart | 100 | - | - | $\mu \mathrm{s}$ |
| Wait time before mode setting | Twait | - | - | 100 | - | - | $\mu \mathrm{s}$ |

Notes:

* 5 . Reference value for design.
* 6. When POR circuit detects the rise of VDD voltage, it resets internal circuits and initializes the registers. After reset, AK09973D transits to Power-down mode.
[Voltage waveform of VDD]



### 8.3. AC Characteristics of OD-INT

| Parameter | Symbol | Pin | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Fall time of OD-INT | TfOD | OD-INT | $C L=50 \mathrm{pF}$ <br> $\mathrm{RL}=20 \mathrm{k} \Omega$ (typ.) | - | - | 250 | ns |



Figure 8.1 Condition of operation verification
[Rise time and fall time]


### 8.4. Overall Characteristics

Table 8.1 High sensitivity setting

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Measurement data output bit | DBIT | - | - | 16 | - | Bit |
| Time for measurement | TSM | SDR bit = "0" <br> (Low noise drive) | - | 0.825 | 0.908 | ms |
|  |  | SDR bit = "1" <br> (Low power drive) | - | 0.265 | 0.292 |  |
| Magnetic sensor sensitivity | BSE | $\begin{gathered} \mathrm{Ta}=25^{\circ} \mathrm{C}, \\ \text { SMR bit }=" 0 \text { " } \end{gathered}$ | 0.99 | 1.1 | 1.21 | $\mu \mathrm{T} / \mathrm{LSB}$ |
| Magnetic sensor measurement range* 7 | BRG | $\begin{gathered} \mathrm{Ta}=25^{\circ} \mathrm{C} \\ \text { SMR bit }=" 0 \text { " } \end{gathered}$ | $\pm 32.44$ | $\pm 36.04$ | $\pm 39.64$ | mT |
| Magnetic sensor initial offset ${ }^{*} 8$ | BOF | $\mathrm{Ta}=25^{\circ} \mathrm{C}$ | -500 | - | +500 | LSB |
| Noise* ${ }^{7}$ | NIS | SDR bit = "0" <br> (Low noise drive) | - | 5.5 | - | $\mu$ Trms |
|  |  | $\begin{gathered} \text { SDR bit }=" 1 " \\ \text { (Low power drive) } \end{gathered}$ | - | 15.0 | - |  |

Table 8.2 Wide range setting

| Parameter | Symbol | Condition | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Measurement data output bit | DBIT |  | - | 16 | - | Bit |
| Time for measurement | TSM | SDR bit = "0" (Low noise drive) | - | 0.825 | 0.908 | ms |
|  |  | SDR bit = "1" (Low power drive) | - | 0.265 | 0.292 |  |
| Magnetic sensor sensitivity | BSE | $\begin{aligned} & \mathrm{Ta}=25^{\circ} \mathrm{C}, \\ & \text { SMR bit }=\text { " } 1 \text { " } \end{aligned}$ | 2.79 | 3.1 | 3.41 | $\mu \mathrm{T} / \mathrm{LSB}$ |
| $\begin{gathered} \text { Magnetic sensor } \\ \text { measurement range }{ }^{* 7} \end{gathered}$ | BRG | $\mathrm{Ta}=25^{\circ} \mathrm{C}$, X and Y -axis, SMR bit = " 1 " | $\pm 31.42$ | $\pm 34.91$ | $\pm 38.4$ | mT |
|  |  | $\begin{gathered} \mathrm{Ta}=25^{\circ} \mathrm{C}, \\ \text { Z-axis, } \\ \text { SMR bit }=\text { " } 1 \text { " } \end{gathered}$ | $\pm 91.42$ | $\pm 101.57$ | $\pm 111.73$ |  |
| Magnetic sensor initial offset ${ }^{*} 8$ | BOF | $\mathrm{Ta}=25^{\circ} \mathrm{C}$ | -177 | - | +177 | LSB |
| Noise* ${ }^{7}$ | NIS | SDR bit = "0" (Low noise drive) | - | 6.8 | - | $\mu \mathrm{Trms}$ |
|  |  | SDR bit = "1" (Low power drive) | - | 18.0 | - |  |

## Notes:

* 7. Reference value for design. Under steady magnetic field.
* 8. Value of measurement data register on shipment test without applying magnetic field on purpose .


## 8.5. $\mathrm{I}^{2} \mathrm{C}$ Bus Interface

$1^{2} \mathrm{C}$ bus interface is compliant with Standard mode, Fast mode and Fast mode plus. As for tR and tF , specifications for Fast mode plus are applied.

- Fast mode plus

| Symbol | Parameter | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| fSCL | SCL clock frequency | - | - | 1000 | kHz |
| tHIGH | SCL clock "High" time | 0.26 | - | - | $\mu \mathrm{s}$ |
| tLOW | SCL clock "Low" time | 0.5 | - | - | $\mathrm{\mu s}$ |
| tR | SDA and SCL rise time | - | - | 120 | ns |
| tF | SDA and SCL fall time | - | - | 120 | ns |
| tHD:STA | Start Condition hold time | 0.26 | - | - | $\mu \mathrm{s}$ |
| tSU:STA | Start Condition setup time | 0.26 | - | - | $\mu \mathrm{s}$ |
| tHD:DAT | SDA hold time (vs. SCL falling edge) | 0 | - | - | $\mu \mathrm{s}$ |
| tSU:DAT | SDA setup time (vs. SCL rising edge) | 50 | - | - | ns |
| tSU:STO | Stop Condition setup time | 0.26 | - | - | $\mu \mathrm{s}$ |
| tBUF | Bus free time | 0.5 | - | - | $\mu \mathrm{s}$ |
| tSP | Noise suppression pulse width | - | - | 50 | ns |



Figure $8.2 I^{2} \mathrm{C}$ bus interface timing

## 9. Status Description

9.1. State Transition Diagram

*After reset is completed, all resisters are initialized and AK09973D transits to Power-down mode automatically.

Figure 9.1 State transition diagram

### 9.2. Power States

When VDD is turned on from Vdd = OFF (0 V), all registers in AK09973D are initialized by POR circuit and transit to Power-down mode automatically.

Table 9.1 Power States

| State | VDD | Power state |
| :--- | :--- | :--- |
| 1 | OFF $(0 \mathrm{~V})$ | OFF $(0 \mathrm{~V})$. <br> It does not affect external interface. |
| 2 | 1.65 V to 1.95 V | ON |

## 10. Functional Descriptions

### 10.1. Reset Functions

AK09973D has two types of reset;
I. Power on Reset (POR)

When Vdd rise is detected, POR circuit operates, and AK09973D is reset. After reset is completed, all registers are initialized and AK09973D transits to Power-down mode.
II. Soft reset

AK09973D is reset by setting SRST bit = " 1 ". After reset is completed, all registers are initialized and AK09973D transits to Power-down mode automatically.

### 10.2. Operation modes

AK09973D has following eleven operation modes:
(1) Power-down mode (MODE[4:0] bits = "00h,03h,05h,07h,09h,0Bh,0Dh,0Fh, $\geq 11 \mathrm{~h} ")$
(2) Single measurement mode (MODE[4:0] bits = "01h")
$>$ Sensor is measured for one time and data is output. Transits to Power-down mode (MODE[4:0] bits = "00h") automatically after measurement ended.
(3) Continuous measurement mode 1 (MODE[4:0] bits = "02h")
> Sensor is measured periodically in 5 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(4) Continuous measurement mode 2 (MODE[4:0] bits = " 04 h ")
> Sensor is measured periodically in 10 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(5) Continuous measurement mode 3 (MODE[4:0] bits = "06h")
$>$ Sensor is measured periodically in 20 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(6) Continuous measurement mode 4 (MODE[4:0] bits = "08h")
> Sensor is measured periodically in 50 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(7) Continuous measurement mode 5 (MODE[4:0] bits = "0Ah")
$>$ Sensor is measured periodically in 100 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(8) Continuous measurement mode 6 (MODE[4:0] bits = " $0 \mathrm{Ch}^{\prime}$ ")
> Sensor is measured periodically in 500 Hz . Transits to other operation mode by writing MODE[4:0] bits directly.
(9) Continuous measurement mode 7 (MODE[4:0] bits = "OEh")
> Sensor is measured periodically in 1000 Hz . Transits to other operation mode by writing MODE[4:0] bits directly. This mode only enables when AK09973D is set Low power mode (SDR bit = " 1 "). When set this mode on Low noise mode (SDR bit = " 0 "), sensor is measured periodically in 500 Hz .
(10) Continuous measurement mode 8 (MODE[4:0] bits = " 10 h ")
> Sensor is measured periodically in 2000 Hz . Transits to other operation mode by writing MODE[4:0] bits directly. This mode only enables when AK09973D is set Low power mode (SDR bit = " 1 "). When set this mode on Low noise mode (SDR bit = " 0 "), sensor is measured periodically in 500 Hz .
(11) Self-test mode (STEST bit = " 1 ")
> Self-test mode is used to check if the magnetic sensor is working normally. This mode only enables when AK09973D is set Single measurement mode.

### 10.2.1. Description of Each Operation Mode

### 10.2.1.1. Power-down Mode

Power to almost all internal circuits is turned off, all registers are accessible in Power-down mode and data stored in read/write registers are remained. They can be reset by reset function.

### 10.2.1.2. Single Measurement Mode

When Single measurement mode (MODE[4:0] bits = " 01 h ") is set, magnetic sensor measurement is started. After magnetic sensor measurement and signal processing is finished, measurement magnetic data is stored to measurement data registers (HX, HY, HZ and HV registers), then AK09973D transits to Power-down mode automatically. On transition to Power-down mode, MODE[4:0] bits turns to "0". At the same time, DRDY bit in ST register turns to "1" and SW bits in ST register turn to another state when measurement magnetic data exceed a setup threshold value.

### 10.2.1.3. Continuous Measurement Mode 1,2,3,4,5,6,7 and 8

When Continuous measurement modes ( 1 to 8 ) are set, magnetic sensor measurement is started periodically at $5 \mathrm{~Hz}, 10 \mathrm{~Hz}, 20 \mathrm{~Hz}, 50 \mathrm{~Hz}, 100 \mathrm{~Hz}, 500 \mathrm{~Hz}, 1000 \mathrm{~Hz}$ and 2000 Hz respectively. After magnetic sensor measurement and signal processing is finished, measurement magnetic data is stored to measurement data registers and all circuits except for the minimum circuit required for counting cycle length are turned off (Power Save: PS). When the next measurement timing comes, AK09973D wakes up automatically from PS and starts measurement again.
Continuous measurement mode ends when a different operation mode is set. When user access to Setting Registers (address 20h to 25h), AK09973D stops updating switch states and measurement data registers.

Table 10.1 Continuous measurement modes

| Operation mode | Register setting <br> (MODE[4:0] bits) | Measurement <br> frequency $[\mathrm{Hz}]$ |
| :---: | :---: | :---: |
| Continuous measurement mode 1 | 00010 | 5 |
| Continuous measurement mode 2 | 00100 | 10 |
| Continuous measurement mode 3 | 00110 | 20 |
| Continuous measurement mode 4 | 01000 | 50 |
| Continuous measurement mode 5 | 01010 | 100 |
| Continuous measurement mode 6 | 01100 | 500 |
| Continuous measurement mode 7 | 01110 | 1000 |
| Continuous measurement mode 8 | 10000 | 2000 |



Figure 10.1 Continuous measurement modes

### 10.3. Data Ready

When measurement data is stored and ready to be read, DRDY bit in ST register turns to "1". This is called "Data Ready". When DRDYEN bit in CNTL1 register is "1", OD-INT pin notify user of the Data Ready state. When any of measurement data register (HX,HY,HZ and HV register) is read all the way through or access to Setting Registers (address 20h to 25h), DRDY bit turns to "0".

### 10.3.1. Normal Measurement Data Read Sequence

(1) Check Data Ready or not by any of the following method.

Monitor OD-INT pin
Polling DRDY bit of ST register
When Data Ready, proceed to the next step.
(2) Read ST and measurement data

When ST register and any of measurement data register ( $\mathrm{HX}, \mathrm{HY}, \mathrm{HZ}$ and HV register) is read all the way through, or access to Setting Registers (address 20h to 25h), AK09973D judges that data reading is finished. When data reading is finished, DRDY bit and DOR bit turns to " 0 ".

When measurement data register is accessed, AK09973D judges that data reading is started. Stored measurement data is protected during data reading and data is not updated. By reading measurement data register is finished, this protection is released.


Figure 10.2 Timing chart of Measurement data read


Figure 10.3 Timing chart of ST data read

### 10.3.2. Data Read Start during Measurement

When the sensor is measuring (Measurement period), measurement data registers (HX, HY, HZ and HV register) keep the previous data. Therefore, it is possible to read out data even during measurement period. If data is started to be read during measurement period, previous data is read.


Figure 10.4 Data read start during measuring

### 10.3.3. Data Skip

When Nth data was not read before $(\mathrm{N}+1)$ th measurement ends, Data Ready remains until data is read. In this case, a set of measurement data is skipped so that DOR bit turns to " 1 ". DOR bit turns to " 0 " at the $(\mathrm{N}+2)$ th measurement ended.
When data reading started after Nth measurement ended and did not finish reading before $(\mathrm{N}+1)$ th measurement ended, Nth measurement data is protected to keep correct data. In this case, a set of measurement data is not skipped and stored after finish reading Nth measurement data so that DOR bit $=" 0$ ".


Figure 10.5 Data Skip: When data is not read


Figure 10.6 Data Not Skip: When data read has not been finished before the next measurement end

### 10.3.4. End Operation

Set Power-down mode (MODE[4:0] bits = "00h") to end Continuous measurement mode.

### 10.4. Programmable Switch Function

AK09973D has a programmable switch function created by setting switch threshold values (operating threshold ${ }^{* 9}$ and returning threshold ${ }^{* 10}$ ) and switch function enable bits (SWEN bits* ${ }^{* 11}$ ). When measurement magnetic data exceeds the operating threshold value, switch event bit (SW bits ${ }^{*}{ }^{12}$ ) turns to " 1 ". When measurement magnetic data is lower than the returning threshold, SW bits turns to " 0 ". The switch function is used to check the magnitude relation between the measurement data and the switch threshold values. After the magnetic sensor measurement and signal processing has finished, measurement data is stored to the measurement data register. Then AK09973D compares the measurement data with the defined switch threshold values and outputs the comparison results at the SW bits in ST register. Switch thresholds can be free to set (Settable range: same as measurement range. Settable sensitivity: same as measurement sensitivity).

Notes:

* 9. BOPX[15:0], BOPY[15:0], BOPZ[15:0] and BOPV[15:0]
* 10. BRPX[15:0], BRPY[15:0], BRPZ[15:0] and BRPV[15:0]
* 11. SWXEN bit, SWYEN bit, SWZEN bit and SWVEN bit
* 12. SWX bit, SWY bit, SWZ bit and SWV bit

Table 10.2 Relation between threshold values and SW bit of X-axis* 13

| Relation between <br> BOPX and BRPX | Magnitude relation between <br> measurement data and threshold <br> values | SWX bit <br> result |
| :---: | :---: | :---: |
| $\mathrm{BOPX} \leq \mathrm{BRPX}$ <br> (Switch function disable) | Don't care | Don't care |
| $\mathrm{BOPX}>\mathrm{BRPX}$ <br> (Switch function <br> enable) | $\mathrm{BOPX}<\mathrm{HX}$ | 1 |
|  | $\mathrm{BRPX}>\mathrm{HX}$ | 0 |



Figure 10.7 Relation between threshold values and SW bit of X -axis ${ }^{* 13}$
Note:

* 13. X-axis, Y-axis, Z-axis and sum of squares of 3-axis exhibits the same relationship


### 10.5. Self-test Function

Self-test mode is used to check if the magnetic sensor is working normally. When Self-test mode (STEST bit = "1") and Single measurement mode (MODE[4:0] bits = "01h") are set, magnetic field is generated by the internal magnetic source and magnetic sensor is measured. In the Self-test mode, the settings of Sensor drive select (SDR bit) and Sensor measurement range (SMR bit) are invalid and measurement is performed with Low noise (SDR bit = " 0 ") and High sensitivity (SMR bit = " 0 "). Measurement data is stored to measurement data registers (HX, HY, HZ), then AK09973D transits to Power-down mode automatically.
Data read sequence and functions of read-only registers in Self-test mode is the same as Single measurement mode.
When measurement data read by the self-test sequence is in the range of following table, AK09973D is working normally.

|  | HX[15:0] bits | HY[15:0] bits | HZ[15:0] bits |
| :---: | :---: | :---: | :---: |
| Criteria | $-120 \leq H X \leq 120$ | $-120 \leq H Y \leq 120$ | $60 \leq H Z \leq 400$ |

### 10.6. Error Notification Function

AK09973D has a limitation for measurement range, where the absolute value of X -axis and Y -axis should be smaller than 36.04 mT (High sensitivity mode) or 34.91 mT (Wide range mode) and the absolute value of Z-axis should be smaller than 36.04 mT (High sensitivity mode) or 101.57 mT (Wide range mode). When the magnetic field exceeds this limitation, AK09973D outputs limitation value (fixed value: $36.04 \mathrm{mT}, 34.91 \mathrm{mT}$ or 101.57 mT ) at the X -axis or/and Y -axis or/and Z -axis. This is called magnetic sensor overflow. When magnetic sensor overflow occurs, ERR bit turns to "1". When the magnetic field less than limitation value, measurement data register and ERR bit are updated.

### 10.7. Interrupt Function

AK09973D has Open-drain interrupt pin (OD-INT pin). When CNTL1 register is set and interrupt event occurred, AK09973D outputs selected interrupt event at OD-INT pin. AK09973D can output three type of interrupt events (Switch event, Data ready, Error event) to OD-INT pin. Switch event occurs when measurement data is higher than BOP value and POL bit ${ }^{* 14}=$ " 0 " or when measurement data is lower than BRP value and POL bit = "1". When interrupt Switch event or Data ready or Error event occurs, OD-INT pin turns to "L".

Note:
*14. POLX bit, POLY bit, POLZ bit and POLV bit
Table 10.3 Relation between threshold values of X-axis and OD-INT pin* 15

| Relation between <br> BOPX and BRPX | Magnitude relation between <br> measurement data and threshold <br> values | OD-INT pin |  |
| :---: | :---: | :---: | :---: |
|  |  | POLX = "0"" | POLX = "1" |
| $\mathrm{BOPX} \leq \mathrm{BRPX}$ <br> (Switch function disable) | Don't care | Don't care |  |
| BOPX $>\mathrm{BRPX}$ <br> (Switch function <br> enable) | $\mathrm{BOPX}<\mathrm{HX}$ | L | H |

## Note:

* 15. X-axis, Y-axis, Z-axis and sum of squares of 3-axis exhibits the same relationship


Figure 10.8 Open drain interrupt pin (POL bit = "0")


Figure 10.9 Open drain interrupt pin (POL bit = " 1 ")

### 10.7.1. Interrupt Event

(1) Switch interrupt event
> When measurement magnetic data exceeds the operating threshold value and POL bit = " 0 ", SW bit turns to " 1 " and OD-INT pin turns to " L ". When measurement magnetic data is lower than the returning threshold and POL bit = " 0 ", SW bit turns to " 0 " and OD-INT pin turns to " H ". In case of POL bit = " 1 ", the polarity of OD-INT pin is the reverse of when POL bit = " 0 ".
(2) Data ready
> OD-INT pin notifies user of the Data Ready state. When Data ready is occurred, DRDY bit turns to " 1 " and OD-INT pin turns to "L". When user accesses to register address, OD-INT pin turns to " H ".
(3) Error event (Overflow)
> When magnetic sensor overflow occurs, ERR bit turns to " 1 " and OD-INT pin turns to "L". When the magnetic field less than limitation value, ERR bit turns to " 0 " and OD-INT pin turns to "H".

### 10.7.2. Timing of DRDY Interrupt Function Operation

Timing of interrupt function operation is given below.
Table 10.3 Timing of interrupt function operation

| Pin name | Output transition | Timing of transition | Remarks |
| :---: | :---: | :---: | :---: |
| OD-INT pin | $\mathrm{H} \rightarrow \mathrm{L}$ | End of measurement | - |
|  | $\mathrm{L} \rightarrow \mathrm{H}$ | Read address 10h - 1Fh <br> or <br> Write address 20h-25h | During access to <br> address, OD-INT pin <br> is always "H" state. |



Figure 10.10 Timing chart of DRDY interrupt function (Normal read sequence)


Figure 10.11 Timing chart of DRDY interrupt function
(When Nth data is read start immediately before $(\mathrm{N}+1)$ th measurement end)

### 10.7.3. Timing of Switch/Error Interrupt Function Operation

When user assigns OD-INT pin to SW event output or/and Error event output, OD-INT pin notifies user of these event. Timing of these interrupt function operation is given below.

Table 10.5 Timing of SW/ERROR interrupt function operation (POL bit = " 0 ")

| Pin name | Output transition | Timing of transition |
| :---: | :---: | :---: |
| OD-INT pin | $\mathrm{H} \rightarrow \mathrm{L}$ | End of <br> measurement(SW/ERROR) |
|  |  | $\mathrm{L} \rightarrow \mathrm{H}$ |
| End of |  |  |
| measurement(SW/ERROR) |  |  |
| or |  |  |
| Write address 20h - 25h |  |  |



Figure 10.12 Timing chart of SW/ERROR interrupt function


Figure 10.13 Timing chart of DRDY or SW/ERROR interrupt function

### 10.8. Sensor Drive Select

Users can choose "Low power" or "Low noise" drive by the SDR bit.
"Low power" is used to save the current consumption and "Low noise" is used to reduce the noise of AK09973D. When Low noise (SDR bit = "0") is set, output magnetic data noise is more reduced than Low power (about $70 \%$ of Low power). When Low power (SDR bit = " 1 ") is set, average current consumption at 10 Hz repetition rate is saved from $11 \mu \mathrm{~A}$ to $3.5 \mu \mathrm{~A}$ (Vdd $\left.=1.8 \mathrm{~V},+25^{\circ} \mathrm{C}\right)$. Default SDR bit is Low noise drive (SDR bit = " 0 ").

### 10.9. Sensor Measurement Range and Sensitivity Select

Users can choose "High sensitivity (Normal measurement range and high sensitivity)" or "Wide range (Wide measurement range and normal sensitivity)" setting.
"High sensitivity" is used to measure with high magnetic sensitivity and "Wide range" is used to measure strong magnetic field (apply only to Z-axis). When High sensitivity (SMR bit = " 0 ") is set, magnetic sensor sensitivity is about three times higher than Wide range ( $3.1 \mu \mathrm{~T} / \mathrm{LSB} \rightarrow 1.1 \mu \mathrm{~T} / \mathrm{LSB}$ ). When Wide range (SMR bit = " 1 ") is set, $Z$-axis measurement range is about three times wider than High sensitivity ( $Z$-axis measurement range: $\pm 36.04 \mathrm{mT} \rightarrow \pm 101.57 \mathrm{mT}$ ). Default SMR bit is High sensitivity enable (SMR bit = "0").

## 11. Serial Interface

## 11.1. ${ }^{2} \mathrm{C}$ Bus Interface

The $I^{2} \mathrm{C}$ bus interface of AK09973D supports the Standard mode ( 100 kHz max.), the Fast mode (400 kHz max.) and the Fast mode plus ( 1000 kHz max.).

### 11.1.1. Data Transfer

To access AK09973D on the bus, generate a start condition first.
Next, transmit a one-byte slave address including a device address. At this time, AK09973D compares the slave address with its own address. If these addresses match, AK09973D generates an acknowledgement, and then executes READ or WRITE instruction. At the end of instruction execution, generate a stop condition.

### 11.1.1.1. Change of Data

A change of data on the SDA line must be made during "Low" period of the clock on the SCL line. When the clock signal on the SCL line is "High", the state of the SDA line must be stable. (Data on the SDA line can be changed only when the clock signal on the SCL line is "Low".)
During the SCL line is "High", the state of data on the SDA line is changed only when a start condition or a stop condition is generated.


Figure 11.1 Data Change

### 11.1.1.2. Start/Stop Condition

If the SDA line is driven to "Low" from "High" when the SCL line is "High", a start condition is generated. Every instruction starts with a start condition.
If the SDA line is driven to "High" from "Low" when the SCL line is "High", a stop condition is generated. Every instruction stops with a stop condition.


Figure 11.2 Start and stop condition

### 11.1.1.3. Acknowledge

The IC that is transmitting data releases the SDA line (in the "High" state) after sending 1-byte data. The IC that receives the data drives the SDA line to "Low" on the next clock pulse. This operation is referred as an acknowledge. With this operation, whether data has been transferred successfully can be checked. AK09973D generates an acknowledge after receipt of the start condition and slave address.
When a WRITE instruction is executed, AK09973D generates an acknowledge after every byte that is received.
When a READ instruction is executed, AK09973D generates an acknowledge then transfers the data stored at the specified address. Next, AK09973D releases the SDA line then monitors the SDA line. If a master IC generates an acknowledge instead of a stop condition, AK09973D transmits the 8-bit data stored at the next address. If no acknowledge is generated, AK09973D stops data transmission.


Figure 11.3 Generation of acknowledge

### 11.1.1.4. Slave Address

The slave address of AK09973D can be selected from the following list by changing pin connections of IF1 and IF2 pin.

|  | IF1 | IF2 | Slave address |
| :---: | :---: | :---: | :---: |
| Connection 1 | OD-INT | SDA | 10 h |
| Connection 2 | SDA | OD-INT | 11 h |



Figure 11.4 Slave address of Connection 1
The first byte including a slave address is transmitted after a start condition, and an IC to be accessed is selected from the ICs on the bus according to the slave address. When a slave address is transferred, the IC whose device address matches the transferred slave address generates an acknowledge then executes an instruction. The 8th bit (least significant bit) of the first byte is a R/W bit.
When the R/W bit is set to " 1 ", READ instruction is executed. When the R/W bit is set to " 0 ", WRITE instruction is executed.

### 11.1.2. WRITE Instruction

When the R/W bit is set to "0", AK09973D performs write operation.
In write operation, AK09973D generates an acknowledge after receiving a start condition and the first byte (slave address) then receives the second byte. The second byte is used to specify the address of an internal control register and is based on the MSB-first configuration.


Figure 11.5 Register address
After receiving the second byte (register address), AK09973D generates an acknowledge then receives the third byte
The third and the following bytes represent control data. Control data consists of 8-bit and is based on the MSB-first configuration. AK09973D generates an acknowledge after every byte is received. Data transfer always stops with a stop condition generated by the master.


Figure 11.6 Control data
AK09973D can write multiple bytes of data at a time.
After reception of the third byte (control data), AK09973D generates an acknowledge then receives the next data. If additional data is received instead of a stop condition after receiving one byte of data, the address counter inside the LSI chip is automatically incremented and the data is written at the next address.
The address is incremented from 20 h to 25 h . When the address is between 20 h and 25 h , the address is incremented $20 \mathrm{~h} \rightarrow 21 \mathrm{~h} \rightarrow 22 \mathrm{~h} \rightarrow 23 \mathrm{~h} \rightarrow 24 \mathrm{~h} \rightarrow 25 \mathrm{~h}$, and the address goes back to 20 h after 25 h . Actual data is written only to Read/Write registers (Table 12.2).


Figure 11.7 WRITE Instruction
[AK09973D]

### 11.1.3. READ Instruction

When the R/W bit is set to "1", AK09973D performs read operation.
If a master IC generates an acknowledge instead of a stop condition after AK09973D transfers the data at a specified address, the data at the next address can be read.
Address can be 20 h to 25 h . When the address is between 20 h and 25 h , the address is incremented $20 \mathrm{~h} \rightarrow 21 \mathrm{~h} \rightarrow 22 \mathrm{~h} \rightarrow 23 \mathrm{~h} \rightarrow 24 \mathrm{~h} \rightarrow 25 \mathrm{~h}$, and the address goes back to 20h after 25 h .
AK09973D supports one byte read and multiple byte read.

### 11.1.3.1. Current Address Read

AK09973D has an address counter inside the LSI chip. In current address read operation, the data at an address specified by this counter is read.
The internal address counter holds the next address of the most recently accessed address.
For example, if the address most recently accessed (for READ instruction) is address "n", and a current address read operation is attempted, the data at address " $n+1$ " is read.
In current address read operation, AK09973D generates an acknowledge after receiving a slave address for the READ instruction (R/W bit = "1"). Next, AK09973D transfers the data specified by the internal address counter starting with the next clock pulse, then increments the internal counter by one. If the master IC generates a stop condition instead of an acknowledge after AK09973D transmits one byte of data, the read operation stops.

SDA


Figure 11.8 Current address read

### 11.1.3.2. Random Address Read

By random address read operation, data at an arbitrary address can be read.
The random address read operation requires to execute WRITE instruction as dummy before a slave address for the READ instruction (R/W bit = "1") is transmitted. In random read operation, a start condition is first generated then a slave address for the WRITE instruction (R/W bit = "0") and a read address are transmitted sequentially.
After AK09973D generates an acknowledge in response to this address transmission, a start condition and a slave address for the READ instruction (R/W bit = "1") are generated again. AK09973D generates an acknowledge in response to this slave address transmission. Next, AK09973D transfers the data at the specified address then increments the internal address counter by one. If the master IC generates a stop condition instead of an acknowledge after data is transferred, the read operation stops.


Figure 11.9 Random address read

## 12. Registers

### 12.1. Description of Registers

AK09973D has registers of 26 addresses as indicated in Table 12.1. Every address consists of 1-byte to 7-byte data. Data is transferred to or received from the external CPU via the serial interface described previously.

Table 12.1 Register Table

| Address | READ/ WRITE | Description | Byte width | Remarks |
| :---: | :---: | :---: | :---: | :---: |
| 00h | READ | Company ID, Device ID | 4 | Device Information |
| 10h |  | Status | 1 | ST data |
| 11h |  | StatusandMeasurement Magnetic Data | 3 | ST + X-axis data |
| 12h |  |  | 3 | ST + Y-axis data |
| 13h |  |  | 5 | ST + X and Y -axis data |
| 14h |  |  | 3 | ST + Z-axis data |
| 15h |  |  | 5 | ST + X and Z -axis data |
| 16h |  |  | 5 | ST + Y and $Z$-axis data |
| 17h |  |  | 7 | ST + X, Y and Z-axis data |
| 18h |  |  | 5 | ST + Sum of squares of |
| 19h |  | StatusandMeasurement Magnetic Data(upper 8 bits of measurementdata register) | 2 | ST + X-axis data |
| 1Ah |  |  | 2 | ST + Y-axis data |
| 1Bh |  |  | 3 | ST + X and Y -axis data |
| 1Ch |  |  | 2 | ST + Z-axis data |
| 1Dh |  |  | 3 | ST +X and Z -axis data |
| 1Eh |  |  | 3 | ST + Y and Z -axis data |
| 1Fh |  |  | 4 | ST + X, Y and Z-axis data |
| 20h | READ/ WRITE | Control 1 | 2 | Interrupt function settings |
| 21h |  | Control 2 | 1 | Operation Mode, Sensor Drive, Measurement Range and Sensitivity |
| 22h |  | Control 3 <br> (Switch threshold value) | 4 | $X$-axis threshold settings |
| 23h |  |  | 4 | Y-axis threshold settings |
| 24h |  |  | 4 | Z -axis threshold settings |
| 25h |  |  | 4 | Sum of squares of 3 -axis threshold settings |
| 30h |  | Reset | 1 | Soft reset |
| 40h |  | Test | 2 | DO NOT ACCESS |
| 41h | READ |  | 1 | DO NOT ACCESS |

Addresses 20 h to 25 h are compliant with automatic increment function of serial interface respectively. When the address is in 20 h to 25 h , the address is incremented $20 \mathrm{~h} \rightarrow 21 \mathrm{~h} \rightarrow 22 \mathrm{~h} \rightarrow 23 \mathrm{~h} \rightarrow 24 \mathrm{~h} \rightarrow$ 25 h , and the address goes back to 20 h after 25 h .

### 12.2. Register Map

Table 12.2 Register Map

| Addr. | Byte0 | Byte1 | Byte2 | Byte3 | Byte4 | Byte5 | Byte6 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read only register |  |  |  |  |  |  |  |
| 00h | WIA[15:8] | WIA[7:0] | RSV[15:8] | RSV[7:0] | - | - | - |
| 10h | ST[7:0] | - | - | - | - | - | - |
| 11h | ST[7:0] | HX[15:8] | HX[7:0] | - | - | - | - |
| 12h | ST[7:0] | HY[15:8] | HY[7:0] | - | - | - | - |
| 13h | ST[7:0] | HY[15:8] | HY[7:0] | HX[15:8] | HX[7:0] | - | - |
| 14h | ST[7:0] | HZ[15:8] | HZ[7:0] | - | - | - | - |
| 15h | ST[7:0] | HZ[15:8] | HZ[7:0] | HX[15:8] | HX[7:0] | - | - |
| 16h | ST[7:0] | HZ[15:8] | HZ[7:0] | HY[15:8] | HY[7:0] | - | - |
| 17h | ST[7:0] | HZ[15:8] | HZ[7:0] | HY[15:8] | HY[7:0] | HX[15:8] | HX[7:0] |
| 18h | ST[7:0] | HV[31:24] | HV[23:16] | HV[15:8] | HV[7:0] |  | - |
| 19h | ST[7:0] | HX[15:8] | - | - | - | - | - |
| 1Ah | ST[7:0] | HY[15:8] | - | - | - | - | - |
| 1Bh | ST[7:0] | HY[15:8] | HX[15:8] | - | - | - | - |
| 1Ch | ST[7:0] | HZ[15:8] | - | - | - | - | - |
| 1Dh | ST[7:0] | HZ[15:8] | HX[15:8] | - | - | - | - |
| 1Eh | ST[7:0] | HZ[15:8] | HY[15:8] | - | - | - | - |
| 1Fh | ST[7:0] | HZ[15:8] | HY[15:8] | HX[15:8] | - | - | - |
| Read/Write register |  |  |  |  |  |  |  |
| 20h | CNTL1[15:8] | CNTL1[7:0] |  | - | - | - | - |
| 21h | CNTL2[7:0] | , | - | - | - | - | - |
| 22h | BOPX[15:8] | BOPX[7:0] | BRPX[15:8] | BRPX[7:0] | - | - | - |
| 23h | BOPY[15:8] | BOPY[7:0] | BRPY[15:8] | BRPY[7:0] | - | - | - |
| 24h | BOPZ[15:8] | BOPZ[7:0] | BRPZ[15:8] | BRPZ[7:0] | - | - | - |
| 25h | BOPV[15:8] | BOPV[7:0] | BRPV[15:8] | BRPV[7:0] | - | - | - |
| 30h | SRST[7:0] | - | - | - | - | - | - |
| 40h | TEST1[15:8] | TEST1[7:0] | - | - | - | - | - |
| 41h | TEST2[7:0] | - | - | - | - | - | - |

Table 12.3 Further details about Register Map (D[7:0])

| Register name | Bit number (D[7:0]) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| WIA[7:0] | 1 | 1 | 0 | 0 | 0 | 0 | 0 | 1 |
| RSV[7:0] | RSV7 | RSV6 | RSV5 | RSV4 | RSV3 | RSV2 | RSV1 | RSV0 |
| ST[7:0] | 1 | DOR | ERR | SWV | SWZ | SWY | SWX | DRDY |
| HX[7:0] | HX7 | HX6 | HX5 | HX4 | HX3 | HX2 | HX1 | HX0 |
| HY[7:0] | HY7 | HY6 | HY5 | HY4 | HY3 | HY2 | HY1 | HYO |
| HZ[7:0] | HZ7 | HZ6 | HZ5 | HZ4 | HZ3 | HZ2 | HZ1 | HZO |
| HV[7:0] | HV7 | HV6 | HV5 | HV4 | HV3 | HV2 | HV1 | HV0 |
| CNTL1[7:0] | 0 | 0 | ERROREN | SWVEN | SWZEN | SWYEN | SWXEN | DRDYEN |
| CNTL2[7:0] | SELFT | SMR | SDR | MODE4 | MODE3 | MODE2 | MODE1 | MODE0 |
| BOPX[7:0] | BOPX7 | BOPX6 | BOPX5 | BOPX4 | BOPX3 | BOPX2 | BOPX1 | BOPX0 |
| BRPX[7:0] | BRPX7 | BRPX6 | BRPX5 | BRPX4 | BRPX3 | BRPX2 | BRPX1 | BRPX0 |
| BOPY[7:0] | BOPY7 | BOPY6 | BOPY5 | BOPY4 | BOPY3 | BOPY2 | BOPY1 | BOPY0 |
| BRPY[7:0] | BRPY7 | BRPY6 | BRPY5 | BRPY4 | BRPY3 | BRPY2 | BRPY1 | BRPY0 |
| BOPZ[7:0] | BOPZ7 | BOPZ6 | BOPZ5 | BOPZ4 | BOPZ3 | BOPZ2 | BOPZ1 | BOPZ0 |
| BRPZ[7:0] | BRPZ7 | BRPZ6 | BRPZ5 | BRPZ4 | BRPZ3 | BRPZ2 | BRPZ1 | BRPZ0 |
| BOPV[7:0] | BOPV7 | BOPV6 | BOPV5 | BOPV4 | BOPV3 | BOPV2 | BOPV1 | BOPV0 |
| BRPV[7:0] | BRPV7 | BRPV6 | BRPV5 | BRPV4 | BRPV3 | BRPV2 | BRPV1 | BRPV0 |
| SRST[7:0] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | SRST |
| TEST1[7:0] | - | - | - | - | - | - | - | - |
| TEST2[7:0] | - | - | - | - | - | - | - | - |

Table 12.4 Further details about Register Map (D[15:8])

| Register name | Bit number (D[15:8]) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
| WIA[15:8] | 0 | 1 | 0 | 0 | 1 | 0 | 0 | 0 |
| RSV[15:8] | RSV15 | RSV14 | RSV13 | RSV12 | RSV11 | RSV10 | RSV9 | RSV8 |
| HX[15:8] | HX15 | HX14 | HX13 | HX12 | HX11 | HX10 | HX9 | HX8 |
| HY[15:8] | HY15 | HY14 | HY13 | HY12 | HY11 | HY10 | HY9 | HY8 |
| HZ[15:8] | HZ15 | HZ14 | HZ13 | HZ12 | HZ11 | HZ10 | HZ9 | HZ8 |
| HV[15:8] | HV15 | HV14 | HV13 | HV12 | HV11 | HV10 | HV9 | HV8 |
| CNTL1[15:8] | 0 | 0 | 0 | 0 | POLV | POLZ | POLY | POLX |
| BOPX[15:8] | BOPX15 | BOPX14 | BOPX13 | BOPX12 | BOPX11 | BOPX10 | BOPX9 | BOPX8 |
| BRPX[15:8] | BRPX15 | BRPX14 | BRPX13 | BRPX12 | BRPX11 | BRPX10 | BRPX9 | BRPX8 |
| BOPY[15:8] | BOPY15 | BOPY14 | BOPY13 | BOPY12 | BOPY11 | BOPY10 | BOPY9 | BOPY8 |
| BRPY[15:8] | BRPY15 | BRPY14 | BRPY13 | BRPY12 | BRPY11 | BRPY10 | BRPY9 | BRPY8 |
| BOPZ[15:8] | BOPZ15 | BOPZ14 | BOPZ13 | BOPZ12 | BOPZ11 | BOPZ10 | BOPZ9 | BOPZ8 |
| BRPZ[15:8] | BRPZ15 | BRPZ14 | BRPZ13 | BRPZ12 | BRPZ11 | BRPZ10 | BRPZ9 | BRPZ8 |
| BOPV[15:8] | BOPV15 | BOPV14 | BOPV13 | BOPV12 | BOPV11 | BOPV10 | BOPV9 | BOPV8 |
| BRPV[15:8] | BRPV15 | BRPV14 | BRPV13 | BRPV12 | BRPV11 | BRPV10 | BRPV9 | BRPV8 |
| TEST1[15:8] | - | - | - | - | - | - | - | - |

Table 12.5 Further details about Register Map (D[23:16])

| Register name | Bit number (D[23:16]) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| HV[23:16] | HV23 | HV22 | HV21 | HV20 | HV19 | HV18 | HV17 | HV16 |

Table 12.6 Further details about Register Map (D[31:24])

| Register name | Bit number (D[31:24]) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 |
| HV[31:24] | HV31 | HV30 | HV29 | HV28 | HV27 | HV26 | HV25 | HV24 |

TEST1 and TEST2 are test registers for shipment test. Do not access these registers.

### 12.3. Detailed Description of Registers

### 12.3.1 WIA[15:0]: Company ID and Device ID

| Addr. | Register <br> name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 00h | WIA[7:0] | 1 | 1 | 0 | 0 | 0 | 0 | 0 | 1 |
| Addr. | Register <br> name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 00h | WIA[15:8] | 0 | 1 | 0 | 0 | 1 | 0 | 0 | 0 |

WIA[7:0] bits: Device ID of AK09973D. It is described in one byte and fixed value. C1h: fixed
WIA[15:8] bits: Company ID of AKM. It is described in one byte and fixed value.
48h: fixed

### 12.3.2 RSV[15:0]: Reserved Register

| Addr. | Register <br> name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 00h | RSV[7:0] | RSV7 | RSV6 | RSV5 | RSV4 | RSV3 | RSV2 | RSV1 | RSV0 |
| Addr. | Register <br> name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 00h | RSV[15:8] | RSV15 | RSV14 | RSV13 | RSV12 | RSV11 | RSV10 | RSV9 | RSV8 |

RSV[7:0] bits/ RSV[15:8] bits: Reserved register for AKM.

### 12.3.3 ST[7:0]: Status

| Addr. | Register <br> name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 10h-1fh | ST[7:0] | 1 | DOR | ERR | SWV | SWZ | SWY | SWX | DRDY |
| Reset | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |  |

DRDY bit: Data Ready
"0": Normal
" 1 ": Data is ready
DRDY bit turns to " 1 " when data is ready in Single measurement mode and Continuous measurement mode. It returns to " 0 " when any one of measurement data register ( $\mathrm{HX}, \mathrm{HY}, \mathrm{HZ}$ or/and HV register) is read all the way through or access to Setting Registers (address 20h to 25h).

DOR bit: Data Overrun
"0": Normal
"1": Data overrun
DOR bit turns to " 1 " when data has been skipped in Continuous measurement mode. DOR bit turns to " 0 " at the after both of reading measurement data and the next measurement ended.

SWX bit, SWY bit, SWZ bit, SWV bit
" 0 ": Measurement data of $\mathrm{X}, \mathrm{Y}, \mathrm{Z}$-axis and vector sum of 3 -axis data is lower than returning threshold "1": Measurement data of X, Y, Z-axis and vector sum of 3-axis data is higher than operating threshold

ERR bit: Magnetic sensor overflow
"0": Normal
"1": Magnetic sensor overflow occurred

### 12.3.4 HX[15:0]/HY[15:0]/HZ[15:0]: Measurement Data

| Addr. | Register name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read-only register |  |  |  |  |  |  |  |  |  |
| $\begin{gathered} \text { 11h } \\ 1 \\ 1 \mathrm{fh} \\ \hline \end{gathered}$ | HX[7:0] | HX7 | HX6 | HX5 | HX4 | HX3 | HX2 | HX1 | HXO |
|  | HY[7:0] | HY7 | HY6 | HY5 | HY4 | HY3 | HY2 | HY1 | HYO |
|  | HZ[7:0] | HZ7 | HZ6 | HZ5 | HZ4 | HZ3 | HZ2 | HZ1 | HZO |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | $\begin{gathered} \text { Register } \\ \text { name } \\ \hline \end{gathered}$ | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read-only register |  |  |  |  |  |  |  |  |  |
| $\begin{gathered} \text { 11h } \\ \text { \| } \\ \text { 1fh } \end{gathered}$ | HX[15:8] | HX15 | HX14 | HX13 | HX12 | HX11 | HX10 | HX9 | HX8 |
|  | HY[15:8] | HY15 | HY14 | HY13 | HY12 | HY11 | HY10 | HY9 | HY8 |
|  | HZ[15:8] | HZ15 | HZ14 | HZ13 | HZ12 | HZ11 | HZ10 | HZ9 | HZ8 |
|  | Reset | 0 | , | , | 0 | 0 | 0 | 0 | 0 |

Measurement data of magnetic sensor X -axis/ $/ \mathrm{Y}$-axis/ $/ \mathrm{-axis}$
HX[7:0] bits: X -axis measurement data lower 8 -bit
HX[15:8] bits: X -axis measurement data higher 8-bit
HY[7:0] bits: Y -axis measurement data lower 8-bit
HY[15:8] bits: Y -axis measurement data higher 8-bit
$\mathrm{HZ}[7: 0]$ bits: Z -axis measurement data lower 8 -bit
HZ[15:8] bits: Z -axis measurement data higher 8-bit
Measurement data is stored in two's complement. Measurement range of each axis is -32768 to 32767 in 16-bit output (High sensitivity setting). Measurement range of X and Y -axis are -11264 to 11264 in 16 -bit output, $Z$-axis is -32768 to 32767 in 16 -bit output (Wide range setting).

Table 12.7 Measurement magnetic data format (High sensitivity setting)

| Measurement data (each axis) [15:0] bits |  | Magnetic flux <br> density [mT] | ERR bit |  |
| :---: | :---: | :---: | :---: | :---: |
| Two's complement | Hex | Decimal | $>36.0437$ | 1 |
| 0111111111111111 | 7FFF | 32767 | 36.0437 | 0 |
| 011111111111111 | 7FFF | 32767 | $\mid$ | $\mid$ |
| $\mid$ | $\mid$ | $\mid$ | 0.0011 | 0 |
| 0000000000000001 | 0001 | 1 | 0 | 0 |
| 0000000000000000 | 0000 | 0 | -0.0011 | 0 |
| 1111111111111111 | FFFF | -1 | $\mid$ | $\mid$ |
| $\mid$ | $\mid$ | $\mid$ | -36.0448 | 0 |
| 1000000000000000 | 8000 | -32768 | -36.0448 | 1 |
| 1000000000000000 | 8000 | -32768 |  |  |

Table 12.8 Measurement magnetic data format (Wide range setting, X and Y -axis)

| Measurement data (X and Y axis) [15:0] bits |  | Magnetic flux <br> density [mT] | ERR bit |  |
| :---: | :---: | :---: | :---: | :---: |
| Two's complement | Hex | Decimal |  |  |
| 0010110000000000 | $2 C 00$ | 11264 | $>34.9184$ | 1 |
| 0010110000000000 | $2 C 00$ | 11264 | 34.9184 | 0 |
| 1 | $\mid$ | $\mid$ | $\mid$ | $\mid$ |
| 0000000000000001 | 0001 | 1 | 0.0031 | 0 |
| 0000000000000000 | 0000 | 0 | 0 | 0 |
| 111111111111111 | FFFF | -1 | -0.0031 | 0 |
| $\mid$ | $\mid$ | $\mid$ | $\mid$ | $\mid$ |
| 1101010000000000 | D400 | -11264 | -34.9184 | 0 |
| 1101010000000000 | D400 | -11264 | $<-34.9184$ | 1 |

Table 12.9 Measurement magnetic data format (Wide range setting, Z-axis)

| Measurement data (Z axis) [15:0] bits |  | Magnetic flux <br> density [mT] | ERR bit |  |
| :---: | :---: | :---: | :---: | :---: |
| Two's complement | Hex |  |  | 1 |
| 0111111111111111 | 7FFF | 32767 | 101.5777 | 0 |
| 0111111111111111 | 7FFF | 32767 | $\mid$ | $\mid$ |
| $\mid$ | $\mid$ | $\mid$ | 0.0031 | 0 |
| 0000000000000001 | 0001 | 1 | 0 | 0 |
| 0000000000000000 | 0000 | 0 | -0.0031 | 0 |
| 1111111111111111 | FFFF | -1 | $\mid$ | $\mid$ |
| $\mid$ | $\mid$ | $\mid$ | -101.5808 | 0 |
| 1000000000000000 | 8000 | -32768 | -101.5808 | 1 |
| 1000000000000000 | 8000 | -32768 |  |  |

12.3.5 HV[23:0]: Sum of Squares of 3-axis Measurement Data

| Addr. | Register name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 18h | HV[7:0] | HX7 | HX6 | HX5 | HX4 | HX3 | HX2 | HX1 | HXO |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 18h | HV[15:8] | HX15 | HX14 | HX13 | HX12 | HX11 | HX10 | HX9 | HX8 |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D23 | D22 | D21 | D20 | D19 | D18 | D17 | D16 |
| Read-only register |  |  |  |  |  |  |  |  |  |
| 18h | HV[23:16] | HX23 | HX22 | HX21 | HX20 | HX19 | HX18 | HX17 | HX16 |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D31 | D30 | D29 | D28 | D27 | D26 | D25 | D24 |
|  |  |  |  |  |  |  |  |  |  |
| 18h | HV[31:24] | HX31 | HX30 | HX29 | HX28 | HX27 | HX26 | HX25 | HX24 |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Sum of squares of 3 -axis measurement data.
$H V[31: 0]=(H X[15: 0])^{\wedge} 2+(H Y[15: 0])^{\wedge} 2+(H Z[15: 0])^{\wedge} 2$
HV[7:0] bits: 3 -axis measurement data lower 8 -bit
$\mathrm{HV}[15: 8]$ bits: 3 -axis measurement data middle 8 -bit
HV[23:16] bits: 3 -axis measurement data middle 8 -bit
HV[31:24] bits: 3 -axis measurement data higher 8-bit

### 12.3.6 CNTL1[15:0]: Interrupt Output Setting

| Addr. | Register name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 20h | CNTL1[7:0] | 0 | 0 | ERREN | SWVEN | SWZEN | SWYEN | SWXEN | DRDYEN |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 20h | CNTL1[15:8] | 0 | 0 | RSV* ${ }^{16}$ | 0 | POLV | POLZ | POLY | POLX |
|  | Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

DRDYEN bit: DRDY event output
" 0 ": DRDY event outputs disable
"1": DRDY event outputs enable

SWXEN bit to SWVEN bit: Switch event output
" 0 ": Switch event outputs disable
"1": Switch event outputs enable

ERREN bit: ERR event output
"0": ERR event outputs disable
" 1 ": ERR event outputs enable

POLX, POLY, POLZ and POLV bit: Polarity of interrupt event signal of OD-INT pin setting
" 0 ": Negative logic output
"1": Positive logic output

Note:

* 16 Please write " 0 " on RSV bit when you write on address 20 h .


### 12.3.7 CNTL2[7:0]: Operation Mode, Sensor Drive and Self-test Setting

| Addr. | Register <br> name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 21h | CNTL2[7:0] | STEST | SMR | SDR | MODE4 | MODE3 | MODE2 | MODE1 | MODE0 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |  |

MODE[4:0] bits: Operation mode setting
"01h": Single measurement mode
"02h": Continuous measurement mode 1
" 04 h ": Continuous measurement mode 2
"06h": Continuous measurement mode 3
"08h": Continuous measurement mode 4
"0Ah": Continuous measurement mode 5
" 0 Ch ": Continuous measurement mode 6
"OEh": Continuous measurement mode 7
"10h": Continuous measurement mode 8
"otherwise": Power-down mode
SDR bit: Sensor drive setting
" 0 ": Low noise drive
"1": Low power drive
SMR bit: Measurement range and sensitivity setting
" 0 ": High sensitivity setting
" 1 ": Wide measurement range setting

## STEST bit: Self-test setting

" 0 ": Self-test disable
"1": Self-test enable
12.3.8 BOP and BRP registers: Operating Threshold and Returning Threshold Setting of
Programmable Switch Function

| Addr. | Register name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| $\begin{aligned} & 22 \mathrm{~h} \\ & -\quad \\ & 25 \mathrm{~h} \end{aligned}$ | BOPX[7:0] | BOPX7 | BOPX6 | BOPX5 | BOPX4 | BOPX 3 | BOPX2 | BOPX1 | BOPX0 |
|  | BRPX[7:0] | BRPX7 | BRPX6 | BRPX5 | BRX4 | BRP1X3 | BRPX2 | BRPX1 | BRPX0 |
|  | BOPY[7:0] | BOPY7 | BOPY | BOPY | OPY4 | BOPY | BOPY | BOPY | BOPY |
|  | BRPY[7:0] | BRPY7 | BRPY6 | BRPY5 | BRPY4 | BRPY3 | BRPY2 | BRPY1 | BRPYO |
|  | BOPZ[7:0] | BOPZ7 | BOPZ6 | BOPZ5 | BOPZ4 | BOPZ3 | BOPZ2 | BOPZ1 | BOPZO |
|  | BRPZ[7:0] | BRPZ7 | BRPZ6 | BRPZ5 | BRPZ4 | BRPZ3 | BRPZ2 | BRPZ1 | BRPZO |
|  | BOPV[7:0] | BOPV7 | BOPV6 | BOPV5 | BOPV4 | BOPV3 | BOPV2 | BOPV1 | BOPVO |
|  | BRPV[7:0] | BRPV7 | BRPV6 | BRPV5 | BRPV4 | BRPV3 | BRPV2 | BRPV1 | BRPV0 |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| $\begin{gathered} \hline 22 \mathrm{~h} \\ - \\ 25 \mathrm{~h} \end{gathered}$ | BOPX[15:8] | BOPX15 | BOPX14 | BOPX13 | BOPX12 | BOPX11 | BOPX10 | BOPX9 | BOPX8 |
|  | BRPX[15:8] | BRPX15 | BRPX14 | BRPX13 | BRPX12 | BRPX11 | BRPX10 | BRPX9 | BRPX8 |
|  | BOPY[15:8] | BOPY15 | BOPY14 | BOPY13 | BOPY12 | BOPY11 | BOPY10 | BOPY9 | BOPY8 |
|  | BRPY[15:8] | BRPY15 | BRPY14 | BRPY13 | BRPY12 | BRPY11 | BRPY10 | BRPY9 | BRPY8 |
|  | BOPZ[15:8] | BOPZ15 | BOPZ14 | BOPZ13 | BOPZ12 | BOPZ11 | BOPZ10 | BOPZ9 | BOPZ8 |
|  | BRPZ[15:8] | BRPZ15 | BRPZ14 | BRPZ13 | BRPZ12 | BRPZ11 | BRPZ10 | BRPZ9 | BRPZ8 |
|  | BOPV[15:8] | BOPV15 | BOPV14 | BOPV13 | BOPV12 | BOPV11 | BOPV10 | BOPV9 | BOPV8 |
|  | BRPV[15:8] | BRPV15 | BRPV14 | BRPV13 | BRPV12 | BRPV11 | BRPV10 | BRPV9 | BRPV8 |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Operating threshold data of magnetic sensor X -axis $/ \mathrm{Y}$-axis/Z-axis BOPX[7:0] bits: X -axis operating threshold data lower 8 -bit BOPX[15:8] bits: X -axis operating threshold data higher 8 -bit BOPY[7:0] bits: Y -axis operating threshold data lower 8-bit BOPY[15:8] bits: Y -axis operating threshold data higher 8-bit BOPZ[7:0] bits: $Z$-axis operating threshold data lower 8 -bit BOPZ[15:8] bits: Z-axis operating threshold data higher 8-bit BOPV[7:0] bits: Vector sum of 3 -axis operating threshold data lower 8 -bit BOPV[15:8] bits: Vector sum of 3 -axis operating threshold data higher 8 -bit

Returning threshold data of magnetic sensor X -axis/ Y -axis/Z-axis BRPX[7:0] bits: X -axis returning threshold data lower 8 -bit BRPX[15:8] bits: X-axis returning threshold data higher 8 -bit BRPY[7:0] bits: Y -axis returning threshold data lower 8-bit BRPY[15:8] bits: Y -axis returning threshold data higher 8-bit BRPZ[7:0] bits: Z-axis returning threshold data lower 8-bit BRPZ[15:8] bits: Z-axis returning threshold data higher 8-bit BRPV[7:0] bits: Vector sum of 3-axis returning threshold data lower 8-bit BRPV[15:8] bits: Vector sum of 3-axis returning threshold data higher 8-bit

AK09973D can set Operating and Returning threshold (X, Y, Z-axis) in two's complement. It follows the same format as Measurement data. Switch thresholds can be free to set.

Table 12.10 Vector sum of 3-axis data format

| Vector sum of 3-axis [15:0] bits |  |  | Magnetic flux density [mT] |  |
| :---: | :---: | :---: | :---: | :---: |
| Two's complement | Hex | Decimal | SMR bit = "0" | SMR bit ="1" |
| 1111111111111111 | FFFF | 65536 | 72.09 | 203.16 |
| $\mid$ | $\mid$ | $\mid$ | $\mid$ | $\mid$ |
| 0000000000000001 | 0001 | 1 | 0.0011 | 0.0031 |
| 0000000000000000 | 0000 | 0 | 0 | 0 |

### 12.3.9 SRST[7:0]: Soft Reset

| Addr. | Register <br> name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 30h | SRST[7:0] | 0 | 0 | 0 | 0 | 0 | 0 | 0 | SRST |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

SRST bit: Soft reset
"0": Normal
"1": Reset
When " 1 " is set, all registers are initialized. After reset, SRST bit turns to " 0 " automatically.
12.3.10 TEST1[15:0]/TEST2[7:0]: Test register

| Addr. | Register name | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 40h | TEST1 | - | - | - | - | - |  | - | - |
| 41h | TEST2 | - | - | - | - | - |  | - | - |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Addr. | Register name | D15 | D14 | D13 | D12 | D11 | D10 | D9 | D8 |
| Read/Write register |  |  |  |  |  |  |  |  |  |
| 40h | TEST1 | - | - | - | - | - | - | - | - |
| Reset |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

TEST1 and TEST2 register are test register for shipment test. Do not access these registers.

Connection1 Slave address: 10h


Connection1 when not using OD-INT


Connection1 when power for I/F is 1.2 V


Connection2 Slave address: 11 h


### 14.1. Outline Dimensions


<Top view>

<Bottom view>

<Side view>

### 14.2. Marking

Product name: 73
Date code: $\quad X_{1} X_{2} X_{3} X_{4} X_{5}$

- $\mathrm{X} 1=I \mathrm{D}$
- X2 = Year code
- X3 = Month code
- X4X5= Lot

$$
\begin{array}{lll}
73 & X_{1} & 0 \\
X_{2} X_{3} & X_{4} X_{5}
\end{array}
$$

<Top view>

### 14.3. Pin Assignment




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